



HIGH-SPEED 32/16K x 16 SYNCHRONOUS DUAL-PORT STATIC RAM

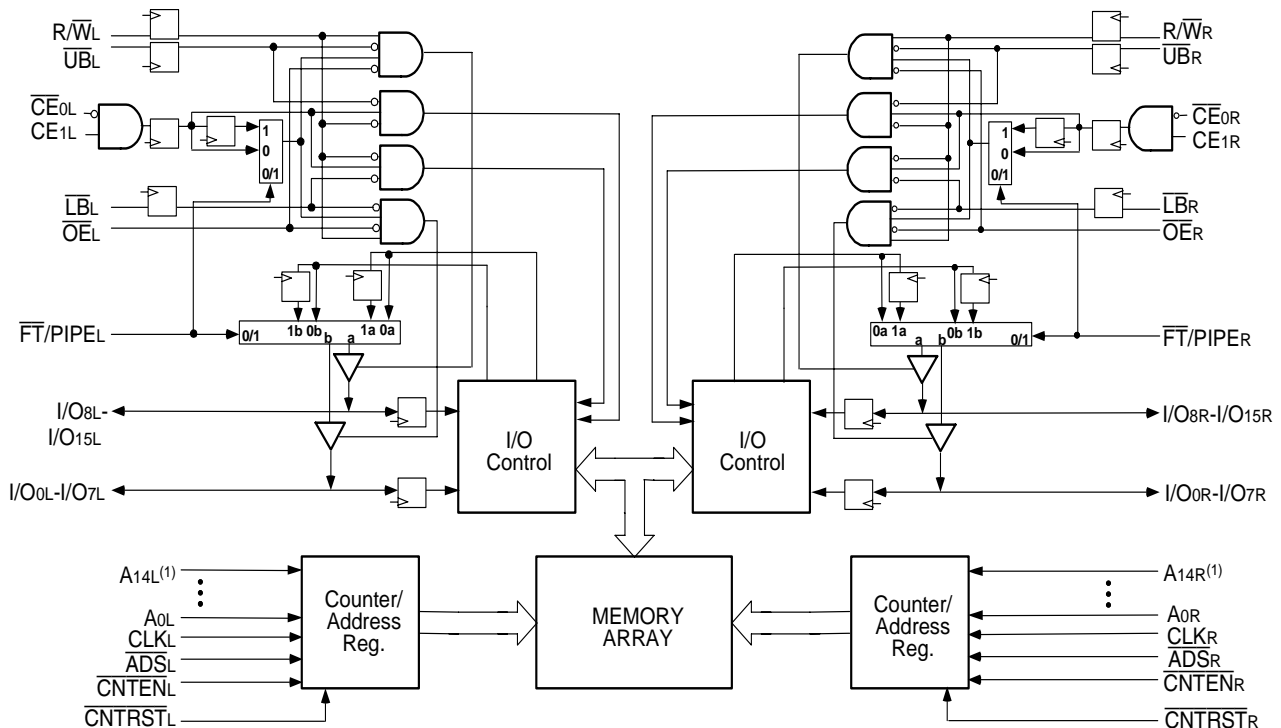
IDT709279/69S/L

LEAD FINISH (SnPb) ARE IN EOL PROCESS - LAST TIME BUY EXPIRES JUNE 15, 2018

Features

- ◆ True Dual-Ported memory cells which allow simultaneous access of the same memory location
- ◆ High-speed clock to data access
 - Commercial: 9/12/15ns (max.)
 - Industrial: 12ns (max.)
- ◆ Low-power operation
 - IDT709279/69S
Active: 950mW (typ.)
Standby: 5mW (typ.)
 - IDT709279/69L
Active: 950mW (typ.)
Standby: 1mW (typ.)
- ◆ Flow-Through or Pipelined output mode on either port via the $\overline{\text{FT}}/\text{PIPE}$ pin
- ◆ Dual chip enables allow for depth expansion without additional logic
- ◆ Counter enable and reset features
- ◆ Full synchronous operation on both ports
 - 4ns setup to clock and 1ns hold on all control, data, and address inputs
 - Data input, address, and control registers
 - Fast 9ns clock to data out in the Pipelined output mode
 - Self-timed write allows fast cycle time
 - 15ns cycle time, 67MHz operation in Pipelined output mode
- ◆ Separate upper-byte and lower-byte controls for multiplexed bus and bus matching compatibility
- ◆ TTL-compatible, single 5V ($\pm 10\%$) power supply
- ◆ Industrial temperature range (-40°C to $+85^{\circ}\text{C}$) is available for selected speeds
- ◆ Available in a 100-pin Thin Quad Flatpack (TQFP) package
- ◆ Green parts available. See ordering information

Functional Block Diagram



3243 drw 01

NOTE:

1. A14x is a NC for IDT709269.

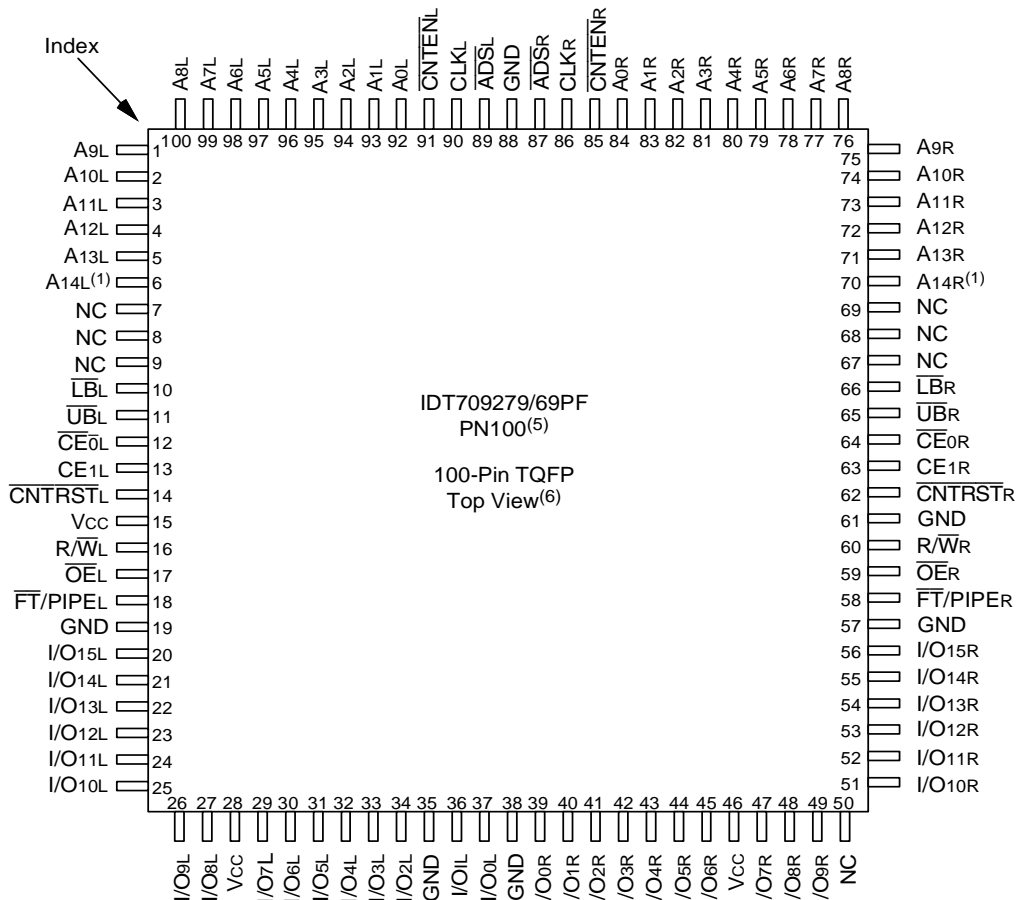
FEBRUARY 2018

Description

The IDT709279/69 is a high-speed 32/16K x 16 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times.

With an input data register, the IDT709279/69 has been optimized for applications having unidirectional or bidirectional data flow in bursts. An automatic power down feature, controlled by $\overline{CE}0$ and $CE1$, permits the on-chip circuitry of each port to enter a very low standby power mode. Fabricated using CMOS high-performance technology, these devices typically operate on only 950mW of power.

Pin Configurations^(2,3,4)



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NOTES:

1. A14x is a NC for IDT709269.
2. All Vcc pins must be connected to power supply.
3. All GND pins must be connected to ground supply.
4. Package body is approximately 14mm x 14mm x 1.4mm
5. This package code is used to reference the package diagram.
6. This text does not indicate orientation of the actual part-marking.

Pin Names

Left Port	Right Port	Names
\overline{CE}_{0L} , CE_{1L}	\overline{CE}_{0R} , CE_{1R}	Chip Enables ⁽³⁾
R/\overline{W}_L	R/\overline{W}_R	Read/Write Enable
\overline{OE}_L	\overline{OE}_R	Output Enable
$A_{0L} - A_{14L}^{(1)}$	$A_{0R} - A_{14R}^{(1)}$	Address
$I/O_{0L} - I/O_{15L}$	$I/O_{0R} - I/O_{15R}$	Data Input/Output
CLK_L	CLK_R	Clock
\overline{UB}_L	\overline{UB}_R	Upper Byte Select ⁽²⁾
\overline{LB}_L	\overline{LB}_R	Lower Byte Select ⁽²⁾
\overline{ADS}_L	\overline{ADS}_R	Address Strobe
\overline{CNTEN}_L	\overline{CNTEN}_R	Counter Enable
\overline{CNTRST}_L	\overline{CNTRST}_R	Counter Reset
$\overline{FT}/PIPE_L$	$\overline{FT}/PIPE_R$	Flow-Through/Pipeline
Vss		Power
GND		Ground

NOTES:

1. A14x is a NC for IDT709269.
2. \overline{LB} and \overline{UB} are single buffered regardless of state of $\overline{FT}/PIPE$.
3. \overline{CE}_0 and CE_1 are single buffered when $\overline{FT}/PIPE = V_{IL}$, \overline{CE}_0 and CE_1 are double buffered when $\overline{FT}/PIPE = V_{IH}$, i.e. the signals take two cycles to deselect.

3243 tbl 01

Truth Table I—Read/Write and Enable Control^(1,2,3)

\overline{OE}	CLK	\overline{CE}_0	CE_1	\overline{UB}	\overline{LB}	R/W	Upper Byte I/O ₈₋₁₅	Lower Byte I/O ₀₋₇	Mode
X	↑	H	X	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	X	L	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	L	H	H	H	X	High-Z	High-Z	Both Bytes Deselected
X	↑	L	H	L	H	L	D _{IN}	High-Z	Write to Upper Byte Only
X	↑	L	H	H	L	L	High-Z	D _{IN}	Write to Lower Byte Only
X	↑	L	H	L	L	L	D _{IN}	D _{IN}	Write to Both Bytes
L	↑	L	H	L	H	H	D _{OUT}	High-Z	Read Upper Byte Only
L	↑	L	H	H	L	H	High-Z	D _{OUT}	Read Lower Byte Only
L	↑	L	H	L	L	H	D _{OUT}	D _{OUT}	Read Both Bytes
H	X	L	H	L	L	X	High-Z	High-Z	Outputs Disabled

NOTES:

1. "H" = V_{IH} , "L" = V_{IL} , "X" = Don't Care.
2. \overline{ADS} , \overline{CNTEN} , \overline{CNTRST} = X.
3. \overline{OE} is an asynchronous input signal.

3243 tbl 02

Truth Table II—Address Counter Control^(1,2)

External Address	Previous Internal Address	Internal Address Used	CLK	\overline{ADS}	\overline{CNTEN}	\overline{CNRST}	I/O ⁽³⁾	MODE
An	X	An	↑	L ⁽⁴⁾	X	H	D _{I/O} (n)	External Address Used
X	An	An + 1	↑	H	L ⁽⁵⁾	H	D _{I/O} (n+1)	Counter Enabled—Internal Address generation
X	An + 1	An + 1	↑	H	H	H	D _{I/O} (n+1)	External Address Blocked—Counter disabled (An + 1 reused)
X	X	A0	↑	X	X	L ⁽⁴⁾	D _{I/O} (0)	Counter Reset to Address 0

3243 tbl 03

NOTES:

- "H" = V_{IH}, "L" = V_{IL}, "X" = Don't Care.
- $\overline{CE_0}$, \overline{LB} , \overline{UB} , and \overline{OE} = V_{IL}; CE₁ and R \overline{W} = V_{IH}.
- Outputs configured in Flow-Through Output mode: if outputs are in Pipelined mode the data out will be delayed by one cycle.
- \overline{ADS} is independent of all other signals including $\overline{CE_0}$, CE₁, \overline{UB} and \overline{LB} .
- The address counter advances if \overline{CNTEN} = V_{IL} on the rising edge of CLK, regardless of all other signals including $\overline{CE_0}$, CE₁, \overline{UB} and \overline{LB} .

Recommended Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	V _{CC}
Commercial	0°C to +70°C	0V	5.0V ± 10%
Industrial	-40°C to +85°C	0V	5.0V ± 10%

3243 tbl 04

NOTES:

- This is the parameter T_A. This is the "instant on" case temperature.

Recommended DC Operating Conditions

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{CC}	Supply Voltage	4.5	5.0	5.5	V
GND	Ground	0	0	0	V
V _{IH}	Input High Voltage	2.2	—	6.0 ⁽¹⁾	V
V _{IL}	Input Low Voltage	-0.5 ⁽²⁾	—	0.8	V

3243 tbl 05

NOTES:

- V_{TERM} must not exceed V_{CC} + 10%.
- V_{IL} ≥ -1.5V for pulse width less than 10ns.

Absolute Maximum Ratings⁽¹⁾

Symbol	Rating	Commercial & Industrial	Unit
V _{TERM} ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +7.0	V
T _{BIAS}	Temperature Under Bias	-55 to +125	°C
T _{STG}	Storage Temperature	-65 to +150	°C
T _{JN}	Junction Temperature	+150	°C
I _{OUT}	DC Output Current	50	mA

3243 tbl 06

NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- V_{TERM} must not exceed V_{CC} + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to ≤ 20mA for the period of V_{TERM} ≥ V_{CC} + 10%.
- Ambient Temperature Under Bias. No AC Conditions. Chip Deselect.

Capacitance⁽¹⁾(T_A = +25°C, f = 1.0MHz)

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0V	9	pF
C _{OUT} ⁽²⁾	Output Capacitance	V _{OUT} = 0V	10	pF

3243 tbl 07

NOTES:

- These parameters are determined by device characterization, but are not production tested.
- C_{OUT} also references C_{I/O}.

DC Electrical Characteristics Over the Operating Temperature Supply Voltage Range ($V_{CC} = 5.0V \pm 10\%$)

Symbol	Parameter	Test Conditions	709279/69S/L		Unit
			Min.	Max.	
$ I_{LI} $	Input Leakage Current ⁽¹⁾	$V_{CC} = 5.5V, V_{IN} = 0V \text{ to } V_{CC}$	—	10	μA
$ I_{LO} $	Output Leakage Current	$CE_0 = V_{IH} \text{ or } CE_1 = V_{IL}, V_{OUT} = 0V \text{ to } V_{CC}$	—	10	μA
V_{OL}	Output Low Voltage	$I_{OL} = +4mA$	—	0.4	V
V_{OH}	Output High Voltage	$I_{OH} = -4mA$	2.4	—	V

3243 tbl 08

NOTE:

- At $V_{CC} \leq 2.0V$ input leakages are undefined.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range⁽⁶⁾ ($V_{CC} = 5V \pm 10\%$)

Symbol	Parameter	Test Condition	Version	709279/69X9 Com'l Only		709279/69X12 Com'l & Ind		709279/69X15 Com'l Only		Unit	
				Typ. ⁽⁴⁾	Max.	Typ. ⁽⁴⁾	Max.	Typ. ⁽⁴⁾	Max.		
ICC	Dynamic Operating Current (Both Ports Active)	$\overline{CE}_L \text{ and } \overline{CE}_R = V_{IL}$ Outputs Disabled $f = f_{MAX}^{(1)}$	COM'L	S	210	390	200	345	190	325	mA
				L	210	350	200	305	190	285	
IND			IND	S	—	—	200	380	—	—	
				L	—	—	200	340	—	—	
ISB1	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L = \overline{CE}_R = V_{IH}$ $f = f_{MAX}^{(1)}$	COM'L	S	50	135	50	110	50	110	mA
				L	50	115	50	90	50	90	
IND			IND	S	—	—	50	125	—	—	
				L	—	—	50	105	—	—	
ISB2	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}^*A = V_{IL}$ and $\overline{CE}^*B = V_{IH}^{(3)}$ Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L	S	140	270	130	230	120	220	mA
				L	140	240	130	200	120	190	
IND			IND	S	—	—	130	245	—	—	
				L	—	—	130	215	—	—	
ISB3	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports \overline{CE}_R and $\overline{CE}_L \geq V_{CC} - 0.2V$ $V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V, f = 0^{(2)}$	COM'L	S	1.0	15	1.0	15	1.0	15	mA
				L	0.2	5	0.2	5	0.2	5	
IND			IND	S	—	—	1.0	15	—	—	
				L	—	—	0.2	5	—	—	
ISB4	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}^*A \leq 0.2V$ and $\overline{CE}^*B \geq V_{CC} - 0.2V^{(5)}$ $V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V$, Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L	S	130	245	120	205	110	195	mA
				L	130	225	120	185	110	175	
IND			IND	S	—	—	120	220	—	—	
				L	—	—	120	200	—	—	

3243 tbl 09

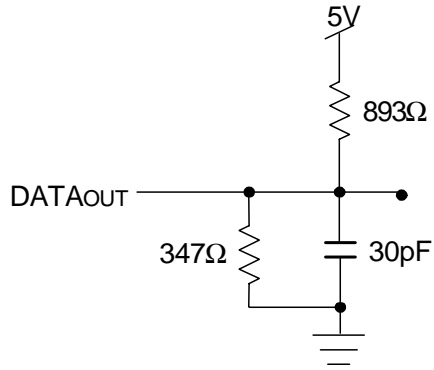
NOTES:

- At $f = f_{MAX}$, address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of $1/t_{CYC}$, using "AC TEST CONDITIONS" at input levels of GND to 3V.
- $f = 0$ means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{CC} = 5V, T_A = 25^\circ C$ for Typ, and are not production tested. $I_{CC} DC(f=0) = 150mA$ (Typ).
- $\overline{CE}_X = V_{IL}$ means $\overline{CE}_{0X} = V_{IL}$ and $CE_{1X} = V_{IH}$
 $\overline{CE}_X = V_{IH}$ means $\overline{CE}_{0X} = V_{IH}$ or $CE_{1X} = V_{IL}$
 $\overline{CE}_X \leq 0.2V$ means $\overline{CE}_{0X} \leq 0.2V$ and $CE_{1X} \geq V_{CC} - 0.2V$
 $\overline{CE}_X \geq V_{CC} - 0.2V$ means $\overline{CE}_{0X} \geq V_{CC} - 0.2V$ or $CE_{1X} \leq 0.2V$
 "X" represents "L" for left port or "R" for right port.
- "X" in part numbers indicate power rating (S or L).

AC Test Conditions

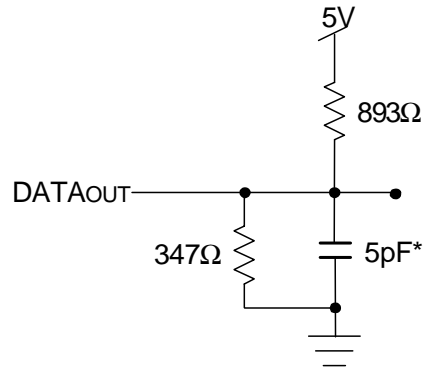
Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	3ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1,2 and 3

3243 tbl 10



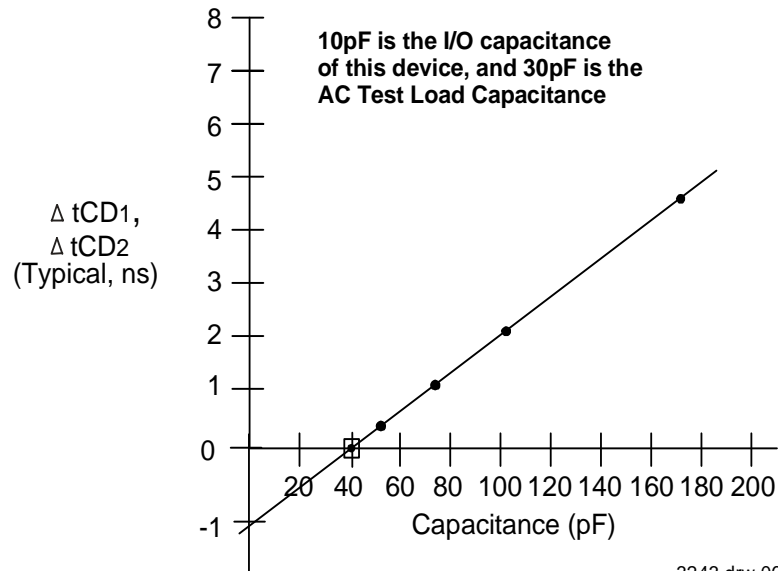
3243 drw 04

Figure 1. AC Output Test load.



3243 drw 05

Figure 2. Output Test Load
(For tCKLZ, tCKHZ, tOLZ, and tOHZ).
*Including scope and jig.



3243 drw 06

Figure 3. Typical Output Derating (Lumped Capacitive Load).

AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing)^(3,4) ($V_{CC} = 5V \pm 10\%$, $T_A = 0^\circ C$ to $+70^\circ C$)

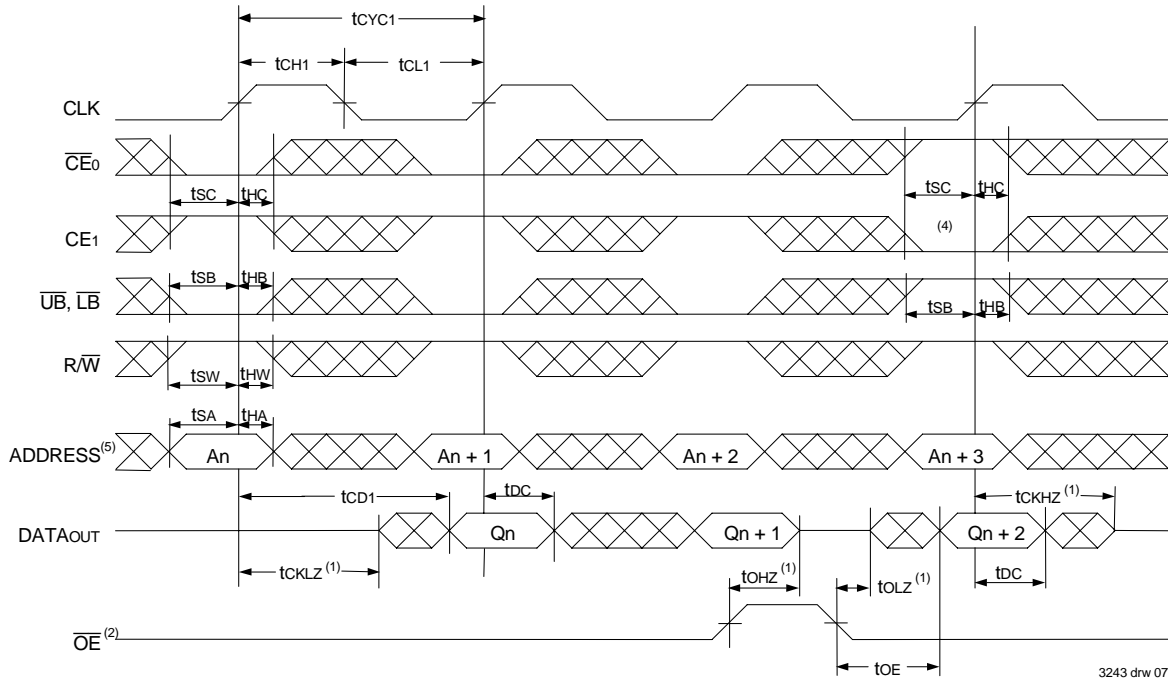
Symbol	Parameter	709279/69X9 Com'l Only		709279/69X12 Com'l & Ind		709279/69X15 Com'l Only		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t _{CYC1}	Clock Cycle Time (Flow-Through) ⁽²⁾	25	—	30	—	35	—	ns
t _{CYC2}	Clock Cycle Time (Pipelined) ⁽²⁾	15	—	20	—	25	—	ns
t _{CH1}	Clock High Time (Flow-Through) ⁽²⁾	12	—	12	—	12	—	ns
t _{CL1}	Clock Low Time (Flow-Through) ⁽²⁾	12	—	12	—	12	—	ns
t _{CH2}	Clock High Time (Pipelined) ⁽²⁾	6	—	8	—	10	—	ns
t _{CL2}	Clock Low Time (Pipelined) ⁽²⁾	6	—	8	—	10	—	ns
t _R	Clock Rise Time	—	3	—	3	—	3	ns
t _F	Clock Fall Time	—	3	—	3	—	3	ns
t _{SA}	Address Setup Time	4	—	4	—	4	—	ns
t _{HA}	Address Hold Time	1	—	1	—	1	—	ns
t _{SC}	Chip Enable Setup Time	4	—	4	—	4	—	ns
t _{HC}	Chip Enable Hold Time	1	—	1	—	1	—	ns
t _{SB}	Byte Enable Setup Time	4	—	4	—	4	—	ns
t _{HB}	Byte Enable Hold Time	1	—	1	—	1	—	ns
t _{SW}	R/W Setup Time	4	—	4	—	4	—	ns
t _{HW}	R/W Hold Time	1	—	1	—	1	—	ns
t _{SD}	Input Data Setup Time	4	—	4	—	4	—	ns
t _{HD}	Input Data Hold Time	1	—	1	—	1	—	ns
t _{SAD}	\overline{ADS} Setup Time	4	—	4	—	4	—	ns
t _{HAD}	\overline{ADS} Hold Time	1	—	1	—	1	—	ns
t _{SCN}	\overline{CNTEN} Setup Time	4	—	4	—	4	—	ns
t _{HCN}	\overline{CNTEN} Hold Time	1	—	1	—	1	—	ns
t _{SRST}	\overline{CNRST} Setup Time	4	—	4	—	4	—	ns
t _{HRST}	\overline{CNRST} Hold Time	1	—	1	—	1	—	ns
t _{OE}	Output Enable to Data Valid	—	9	—	12	—	15	ns
t _{OLZ}	Output Enable to Output Low-Z ⁽¹⁾	2	—	2	—	2	—	ns
t _{OZH}	Output Enable to Output High-Z ⁽¹⁾	1	7	1	7	1	7	ns
t _{CD1}	Clock to Data Valid (Flow-Through) ⁽²⁾	—	20	—	25	—	30	ns
t _{CD2}	Clock to Data Valid (Pipelined) ⁽²⁾	—	9	—	12	—	15	ns
t _{DC}	Data Output Hold After Clock High	2	—	2	—	2	—	ns
t _{CKHZ}	Clock High to Output High-Z ⁽¹⁾	2	9	2	9	2	9	ns
t _{CKLZ}	Clock High to Output Low-Z ⁽¹⁾	2	—	2	—	2	—	ns
Port-to-Port Delay								
t _{CWDD}	Write Port Clock High to Read Data Delay	—	35	—	40	—	50	ns
t _{CSS}	Clock-to-Clock Setup Time	—	15	—	15	—	20	ns

NOTES:

3243 tbl 11

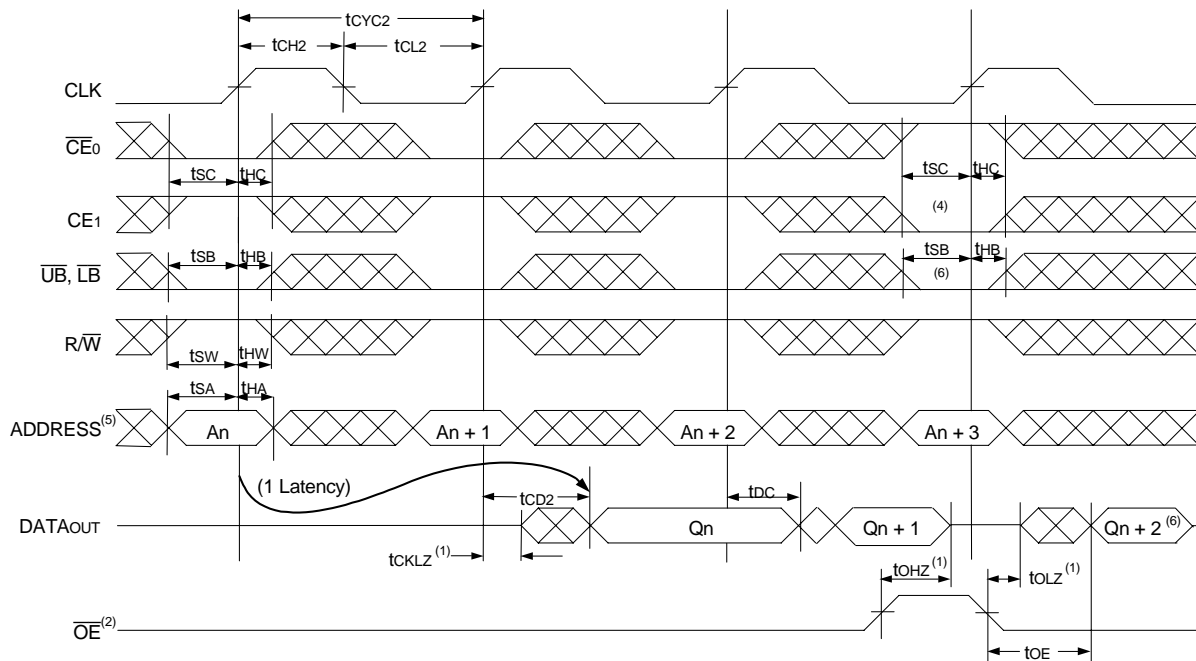
1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2). This parameter is guaranteed by device characterization, but is not production tested.
2. The Pipelined output parameters (t_{CYC2}, t_{CD2}) apply to either or both left and right ports when $\overline{FT}/PIPE = V_{IH}$. Flow-through parameters (t_{CYC1}, t_{CD1}) apply when $\overline{FT}/PIPE = V_{IL}$ for that port.
3. All input signals are synchronous with respect to the clock except for the asynchronous Output Enable (\overline{OE}) and $\overline{FT}/PIPE$. $\overline{FT}/PIPE$ should be treated as a DC signal, i.e. steady state during operation.
4. 'X' in part number indicates power rating (S or L).

Timing Waveform of Read Cycle for Flow-Through Output ($\overline{FT}/PIPE "X" = V_{IL}$)^(3,7)



3243 drw 07

Timing Waveform of Read Cycle for Pipelined Output ($\overline{FT}/PIPE "X" = V_{IH}$)^(3,7)

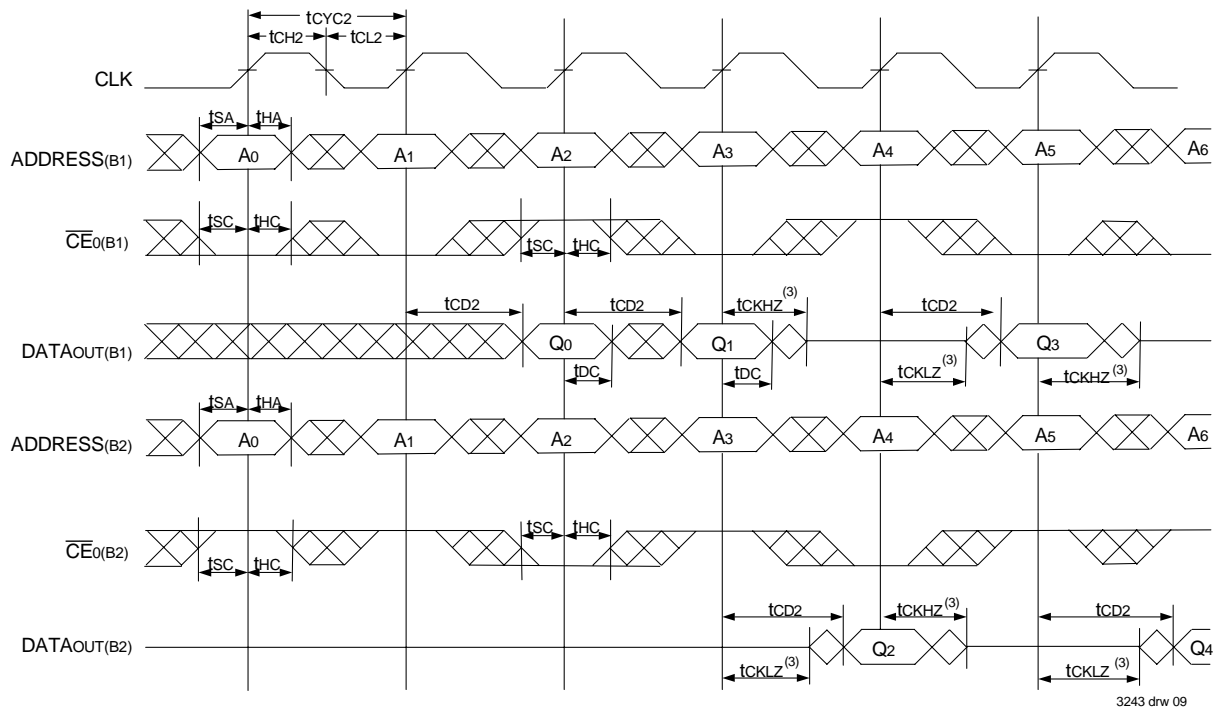


3243 drw 08

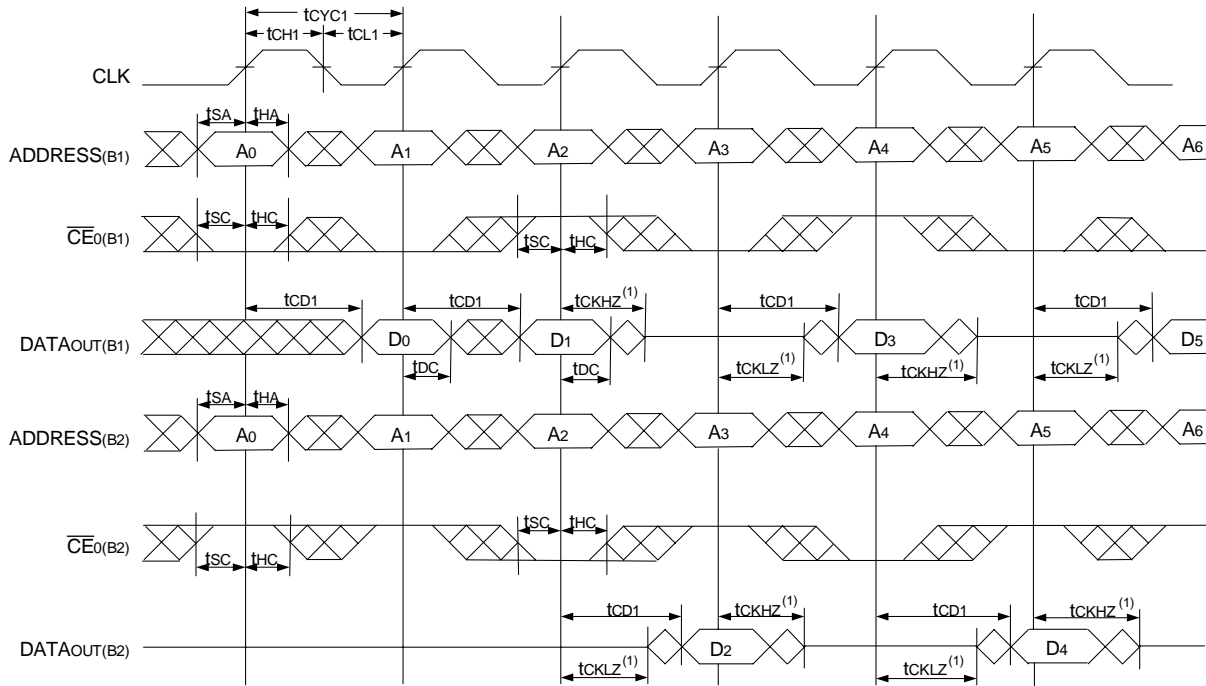
NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. \overline{OE} is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
3. $\overline{ADS} = V_{IL}$, \overline{CNTEN} and $\overline{CNTRST} = V_{IH}$.
4. The output is disabled (High-Impedance state) by $\overline{CE0} = V_{IH}$, $\overline{CE1} = V_{IL}$, $\overline{UB} = V_{IH}$, or $\overline{LB} = V_{IH}$ following the next rising edge of the clock. Refer to Truth Table 1.
5. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
6. If \overline{UB} or \overline{LB} was HIGH, then the Upper Byte and/or Lower Byte of $DATA_{OUT}$ for $Q_n + 2$ would be disabled (High-Impedance state).
7. "x" denotes Left or Right port. The diagram is with respect to that port.

Timing Waveform of a Bank Select Pipelined Read^(1,2)



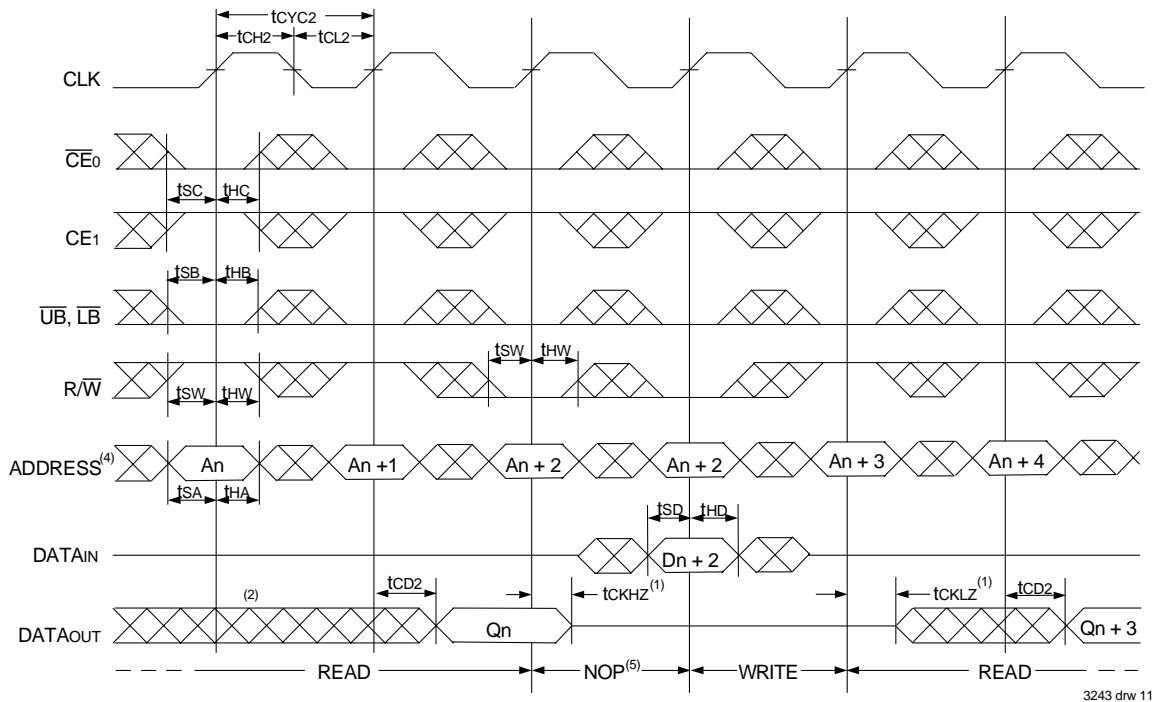
Timing Waveform of a Bank Select Flow-Through Read⁽⁶⁾



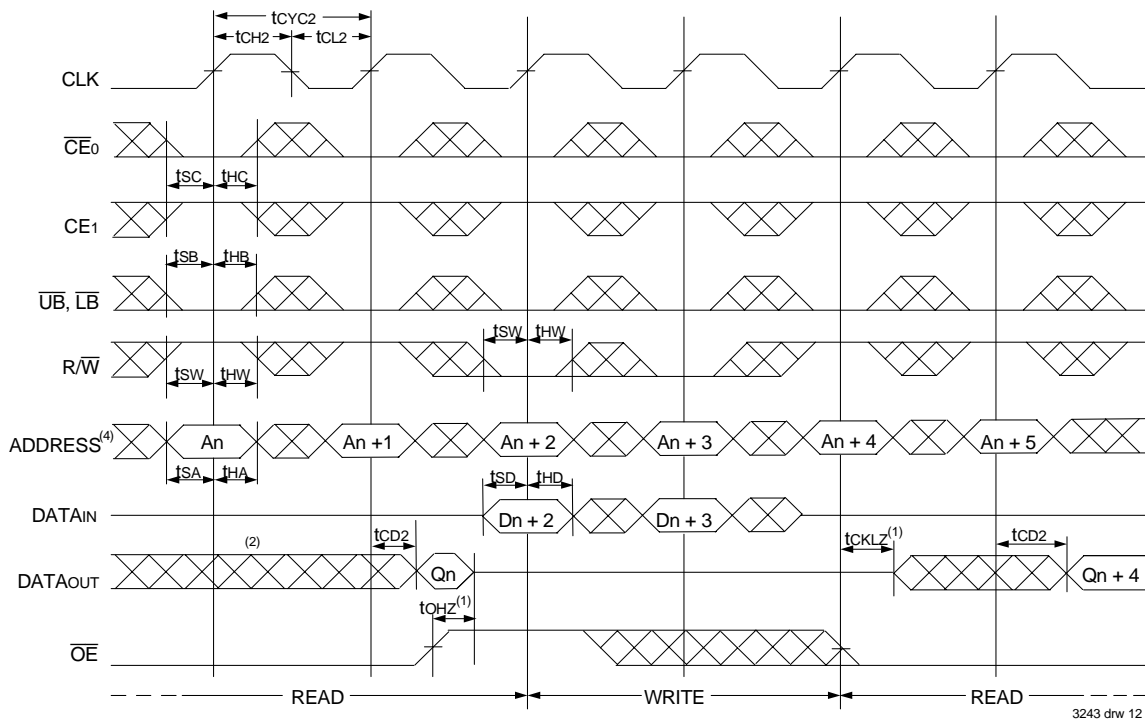
NOTES:

1. B1 Represents Bank #1; B2 Represents Bank #2. Each Bank consists of one IDT709279/69 for this waveform, and are setup for depth expansion in this example. ADDRESS_(B1) = ADDRESS_(B2) in this situation.
2. \overline{UB} , \overline{LB} , \overline{OE} , and \overline{ADS} = V_{IL} ; $CE_{1(B1)}$, $CE_{1(B2)}$, R/W , \overline{CNTEN} , and \overline{CNRST} = V_{IH} .
3. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
4. \overline{CE}_0 , \overline{UB} , \overline{LB} , and \overline{ADS} = V_{IL} ; CE_1 , \overline{CNTEN} , and \overline{CNRST} = V_{IH} .
5. \overline{OE} = V_{IL} for the Right Port, which is being read from. \overline{OE} = V_{IH} for the Left Port, which is being written to.
6. If $t_{CCS} \leq$ maximum specified, then data from right port READ is not valid until the maximum specified for t_{CWDD} .
If $t_{CCS} >$ maximum specified, then data from right port READ is not valid until $t_{CCS} + t_{CD1}$. t_{CWDD} does not apply in this case.

Timing Waveform of Pipelined Read-to-Write-to-Read ($\overline{OE} = V_{IL}$)⁽³⁾



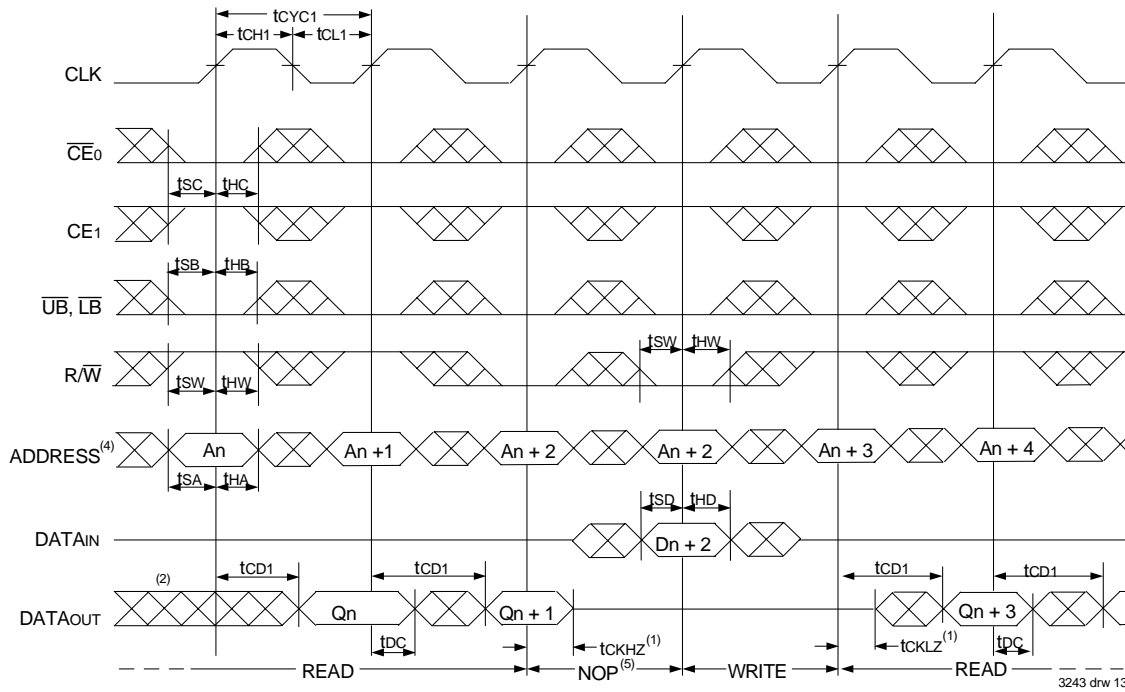
Timing Waveform of Pipelined Read-to-Write-to-Read (OE Controlled)⁽³⁾



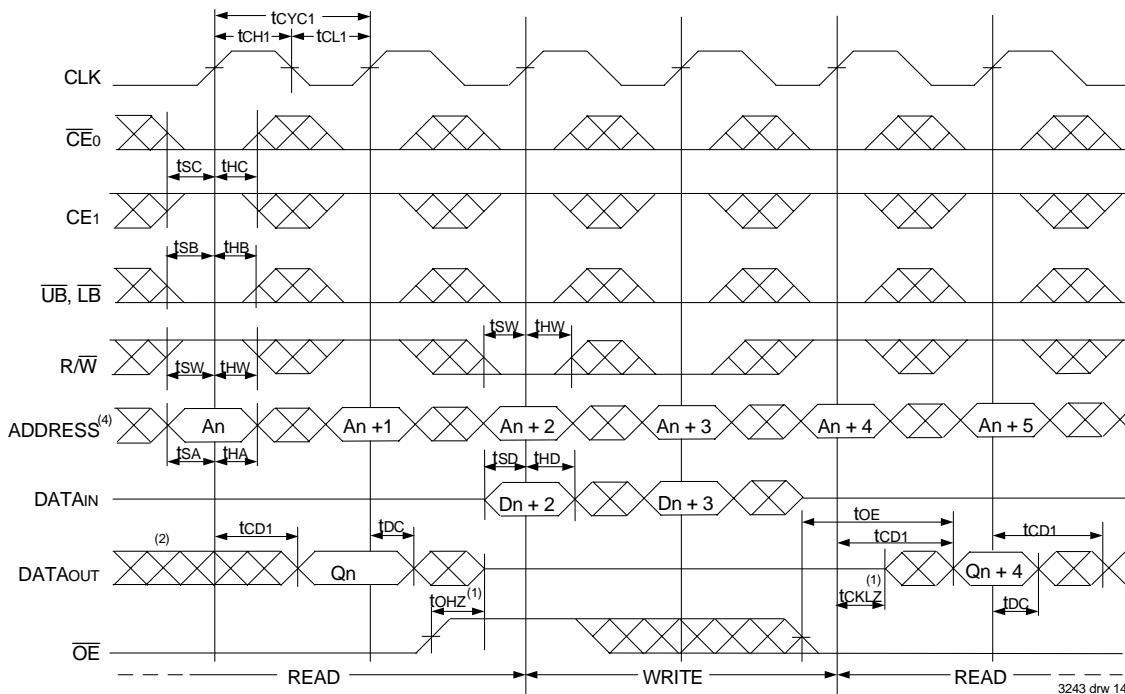
NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3. \overline{CE}_0 , \overline{UB} , \overline{LB} , and $\overline{ADS} = V_{IL}$; CE_1 , \overline{CNTEN} , and $\overline{CNTNST} = V_{IH}$.
4. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Flow-Through Read-to-Write-to-Read ($\overline{OE} = V_{IL}$)⁽³⁾



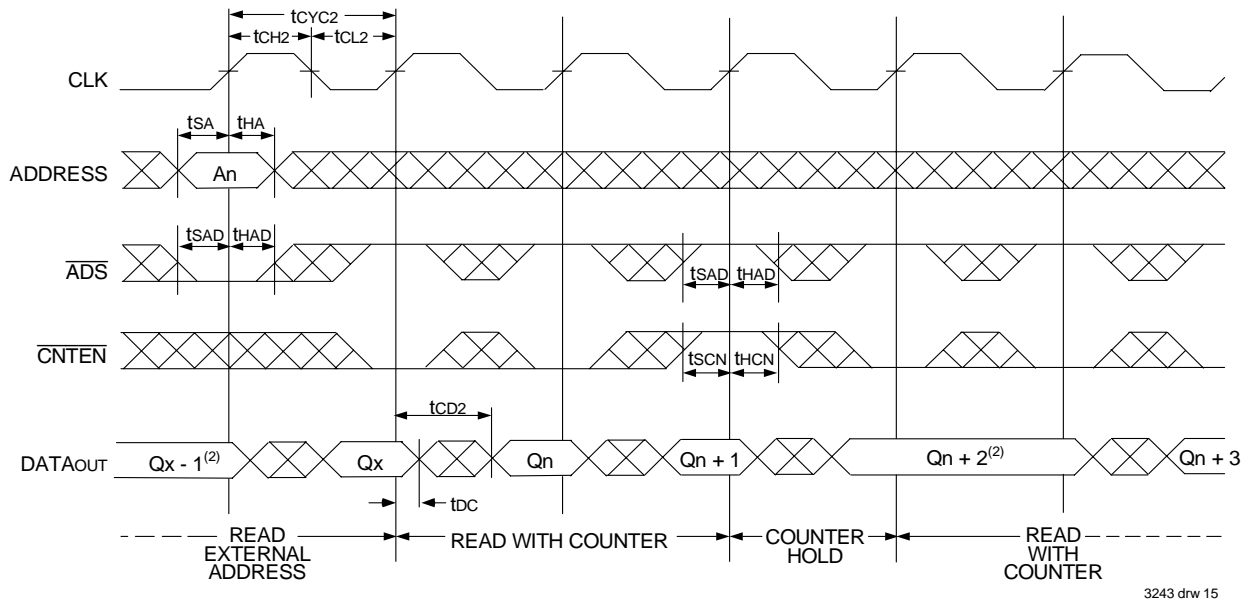
Timing Waveform of Flow-Through Read-to-Write-to-Read (\overline{OE} Controlled)⁽³⁾



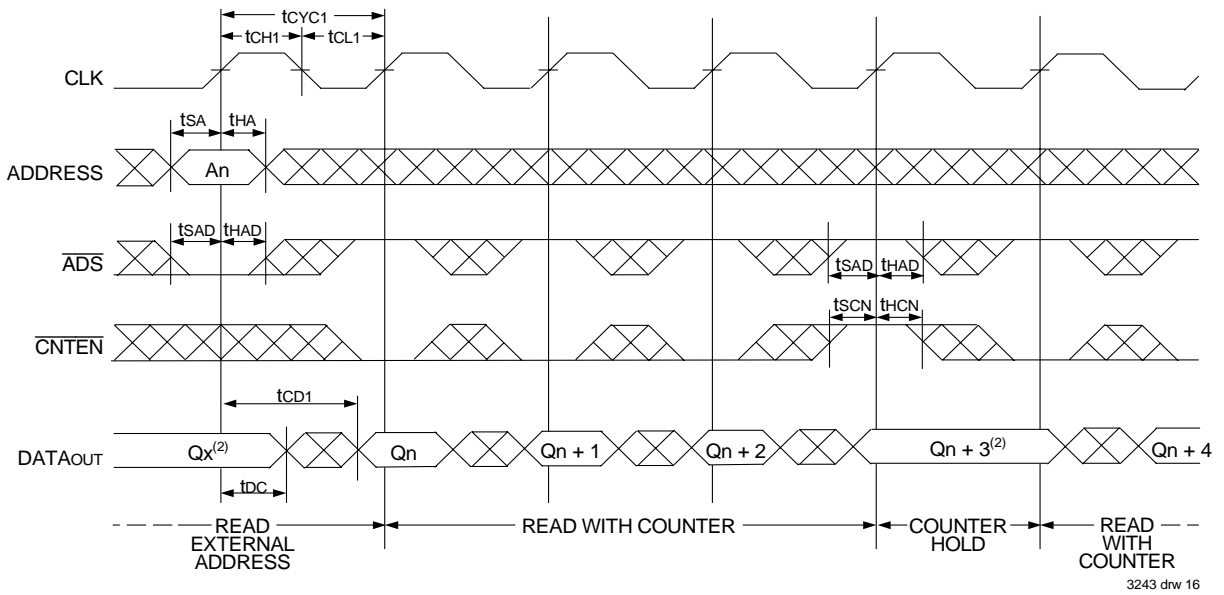
NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
2. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
3. \overline{CE}_0 , \overline{UB} , \overline{LB} , and $\overline{ADS} = V_{IL}$; CE_1 , \overline{CNTEN} , and $\overline{CNTNST} = V_{IH}$.
4. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Pipelined Read with Address Counter Advance⁽¹⁾



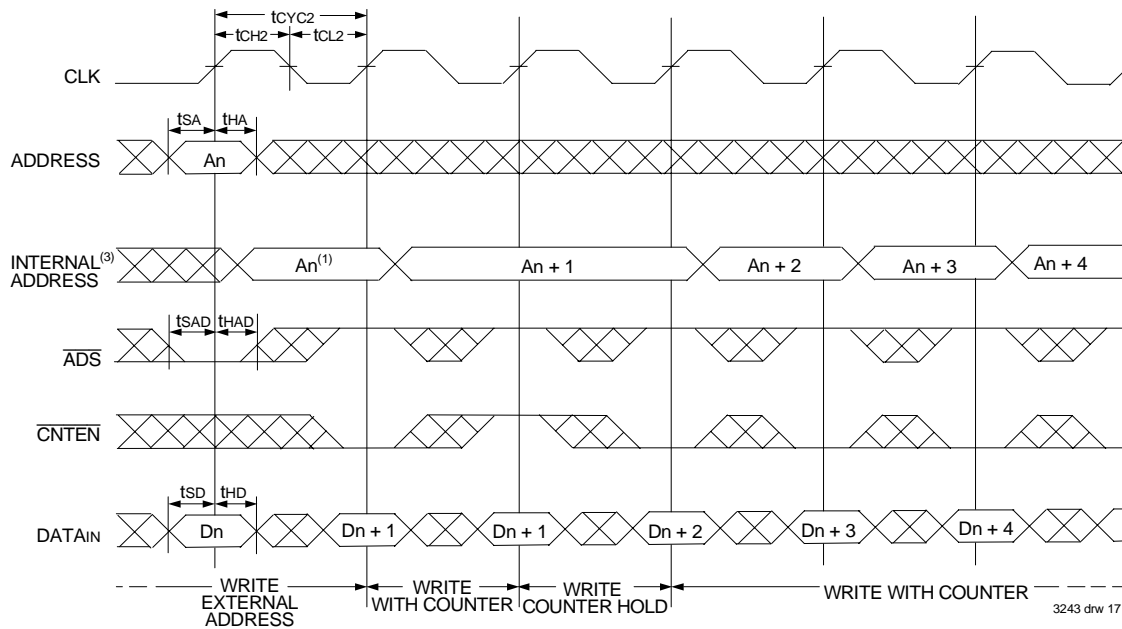
Timing Waveform of Flow-Through Read with Address Counter Advance⁽¹⁾



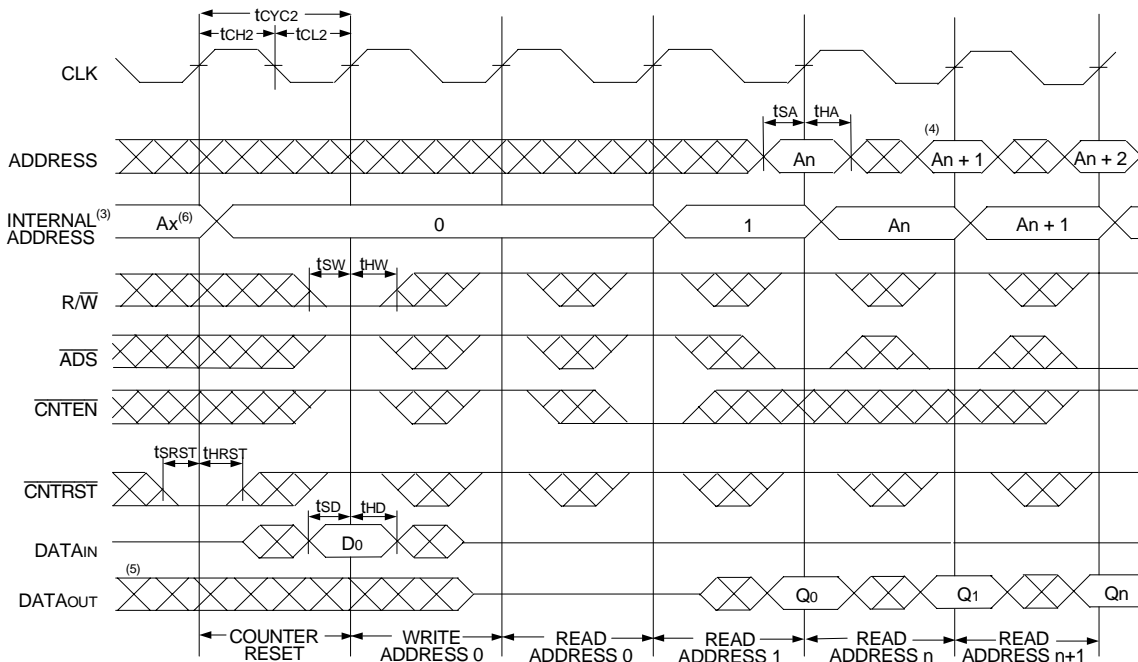
NOTES:

1. \overline{CE}_0 , \overline{OE} , \overline{UB} , and $\overline{LB} = V_{IL}$; CE_1 , R/\overline{W} , and $\overline{CNTRST} = V_{IH}$.
2. If there is no address change via $\overline{ADS} = V_{IL}$ (loading a new address) or $\overline{CNTEN} = V_{IL}$ (advancing the address), i.e. $\overline{ADS} = V_{IH}$ and $\overline{CNTEN} = V_{IH}$, then the data output remains constant for subsequent clocks.

Timing Waveform of Write with Address Counter Advance (Flow-Through or Pipelined Outputs)⁽¹⁾



Timing Waveform of Counter Reset (Pipelined Outputs)⁽²⁾



NOTES:

1. \overline{CE}_0 , \overline{UB} , \overline{LB} , and $R/\overline{W} = V_{IL}$; CE_1 and $\overline{CNTRST} = V_{IH}$.
2. \overline{CE}_0 , \overline{UB} , $\overline{LB} = V_{IL}$; $CE_1 = V_{IH}$.
3. The "Internal Address" is equal to the "External Address" when $\overline{ADS} = V_{IL}$ and equals the counter output when $\overline{ADS} = V_{IH}$.
4. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
6. No dead cycle exists during counter reset. A READ or WRITE cycle may be coincidental with the counter reset cycle. $ADDR_0$ will be accessed. Extra cycles are shown here simply for clarification.
7. $\overline{CNTEN} = V_{IL}$ advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1' Address is written to during this cycle.

A Functional Description

The IDT709279/69 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

An asynchronous output enable is provided to ease asynchronous bus interfacing. Counter enable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

A HIGH on \overline{CE}_0 or a LOW on CE_1 for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT709279/69's for depth expansion configurations. When the Pipelined output mode is enabled, two cycles are required with \overline{CE}_0 LOW and CE_1 HIGH to re-activate the outputs.

Depth and Width Expansion

The IDT709279/69 features dual chip enables (refer to Truth Table 1) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The IDT709279/69 can also be used in applications requiring expanded width, as indicated in Figure 4. Since the banks are allocated at the discretion of the user, the external controller can be set up to drive the input signals for the various devices as required to allow for 32-bit or wider applications.

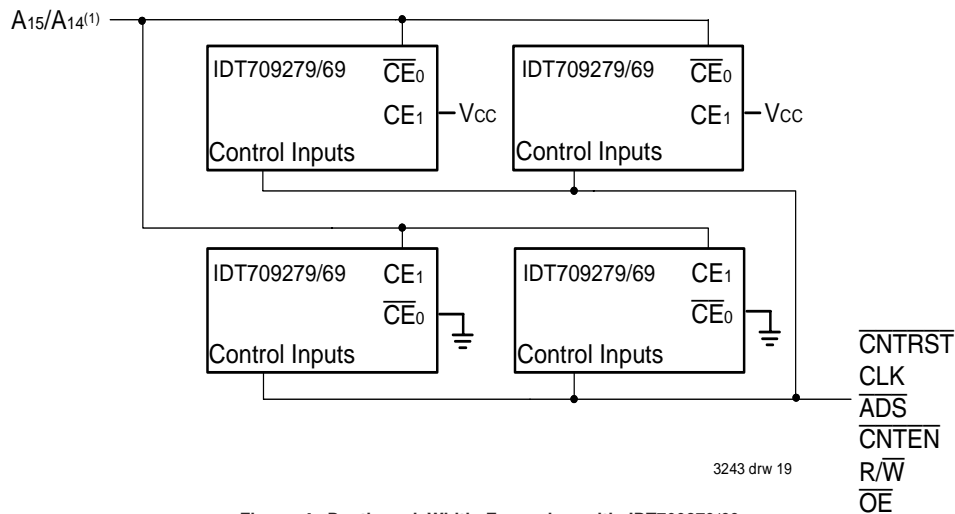
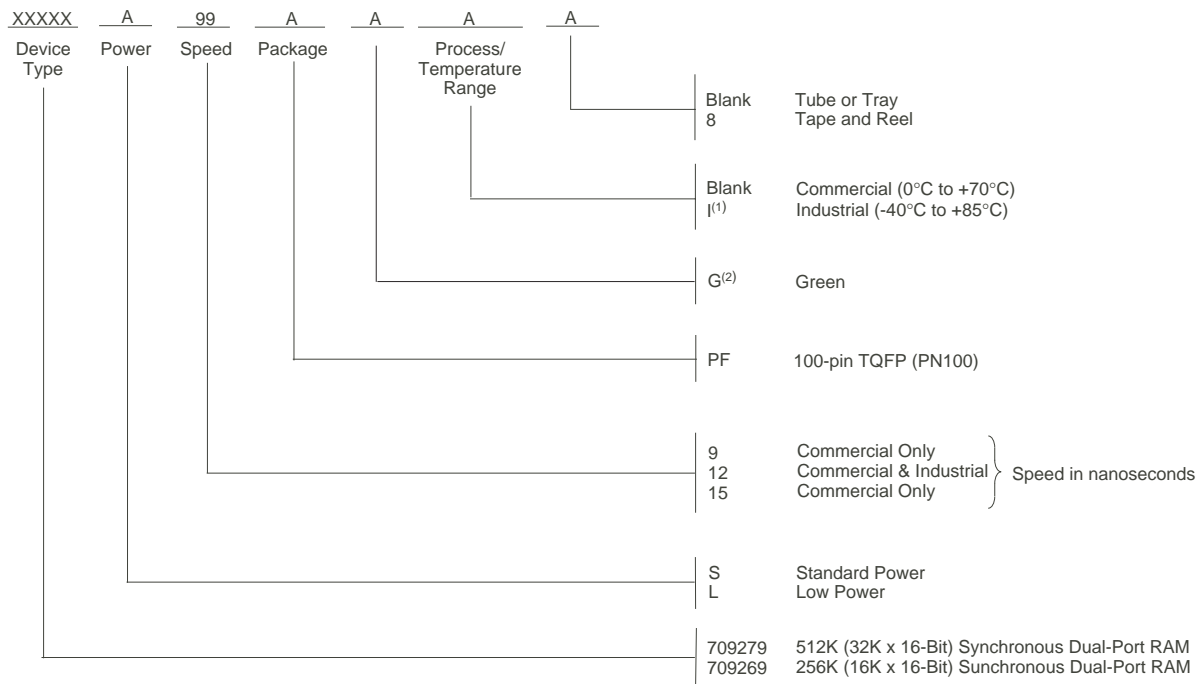


Figure 4. Depth and Width Expansion with IDT709279/69

NOTE:

1. A14 is for IDT709269.

Ordering Information



3243 drw 20

NOTES:

1. Industrial temperature range is available. For specific speeds, packages and powers contact your sales office.
2. Green parts available. For specific speeds, packages and powers contact your local sales office.

LEAD FINISH (SnPb) parts are in EOL process. Product Discontinuation Notice - PDN# SP-17-02

Ordering Information for Flow-through Devices

Old Flow-through Part	New Combined Part
70927S/L20	709279S/L9
70927S/L25	709279S/L12
70927S/L30	709279S/L15

3243 tbl 12

IDT Clock Solution for IDT709279/69 Dual-Port

IDT Dual-Port Part Number	Dual-Port I/O Specifications		Clock Specifications				IDT Non-PLL Clock Device
	Voltage	I/O	Input Capacitance	Input Duty Cycle Requirement	Maximum Frequency	Jitter Tolerance	
709279/69	5	TTL	9pF	40%	100	150ps	49FCT805T

3243 tbl 13

Datasheet Document History

- 12/9/98: Initiated datasheet document history
Converted to new format
Cosmetic and typographical corrections
Added additional notes to pin configurations
Pages 13 & 14 Updated timing waveforms
Page 15 Added Depth and Width Expansion section
- 06/03/99: Changed drawing format
Page 3 Deleted note 6 for Table II
- 11/10/99: Replaced IDT logo
- 03/31/00: Combined Pipelined 709279 family and Flow-through 70927 family offerings into one data sheet
Changed $\pm 200\text{mV}$ in waveform notes to 0mV
Added corresponding part chart with ordering information
- 05/24/00: Page 1 Inserted diamond in copy
Page 4 Changed information in Truth Table II, Increased storage temperature parameter, clarified TA parameter
Page 5 Changed DC Electrical parameters—changed wording from "Open" to "Disabled"
Page 16 Fixed typeface in heading
Added Industrial Temperature Ranges and removed related notes
- 08/24/01: Pages 1, 16 and Page Header Removed Preliminary status
Page 5 & 7 Removed Industrial Temperature Ranges for 15ns speed from DC and AC Electrical Characteristics
Page 16 Removed Industrial Temperature from 15ns speed in ordering information
- 06/21/04: Consolidated multiple devices into one datasheet
Page 2 Added date revision to pin configuration
Page 4 Added Junction Temperature to Absolute Maximum Ratings Table
Added Ambient Temperature footnote
Page 5 & 6 Added 6ns & 7ns speed DC power numbers to the DC Electrical Characteristics Table
Page 8 Added 6ns & 7ns speed AC timing numbers to the AC Electrical Characteristics Table
Page 17 Added 6ns & 7ns speed grades to ordering information
Added IDT Clock Solution Table
Page 1 & 18 Replaced old ® logo with new ™ logo
- 01/29/09: Page 17 Removed "IDT" from orderable part number
- 06/24/15: Page 1 Added green availability to Features
Page 2 Removed IDT in reference to fabrication
Page 2 Removed date from the 100-pin TQFP configuration
Page 2 & 17 The package code PN100-1 changed to PN100 to match standard package codes
Page 5 Removed the X6 & X7 speed grade options and combined the X9, X12 & X15 speed grade options into one DC Elec Chars table
Page 7 Removed the X6 & X7 speed grade options from the AC Elec Chars table
Page 16 Added Green and Tape & Reel indicators to the Ordering Information
- 02/02/18: Product Discontinuation Notice - PDN# SP-17-02
Last time buy expires June 15, 2018



CORPORATE HEADQUARTERS

6024 Silver Creek Valley Road
San Jose, CA 95138

for SALES:

800-345-7015 or 408-284-8200
fax: 408-284-2775
www.idt.com

for Tech Support:

408-284-2794
DualPortHelp@idt.com